

<b>Notice of References Cited</b>	Application/Control No. 10/588,705		Applicant(s)/Patent Under Reexamination WEINLANDER, MARKUS	
	Examiner Erik V. Stitt		Art Unit 2174	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0256084	11-2006	Hey et al.	345/157
*	B	US-6,437,812	08-2002	Giles et al.	715/853
*	C	US-6,008,806	12-1999	Nakajima et al.	715/744
*	D	US-5,701,137	12-1997	Kiernan et al.	715/853
*	E	US-6,212,512	04-2001	Barney et al.	707/1
*	F	US-5,917,492	06-1999	Bereiter et al.	715/854
*	G	US-6,147,687	11-2000	Wanderski, Michael Christian	715/853
*	H	US-2004/0230917	11-2004	Bales et al.	715/854
*	I	US-2002/0124082	09-2002	SAN ANDRES et al.	709/225
*	J	US-6,014,666	01-2000	Helland et al.	707/9
*	K	US-7,017,121	03-2006	Gikas et al.	715/804
*	L	US-6,236,400	05-2001	Guerrero, Jaime F.	715/841
*	M	US-7,171,468	01-2007	Yeung et al.	709/225

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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